

SCHOTTKY DIODES KDN-40060.

PRELIMINARY



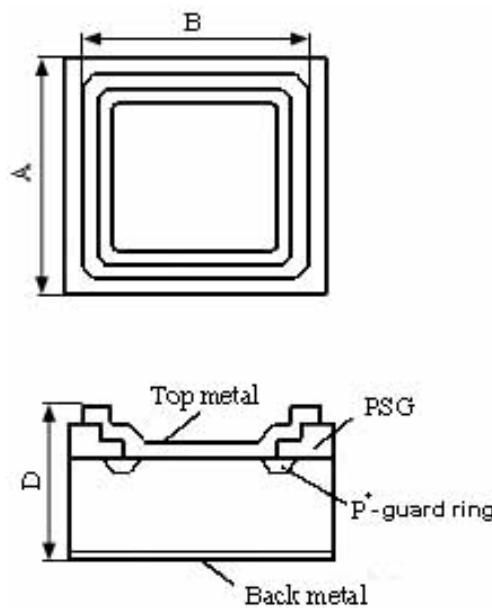
Rev.1. Feb. 2010



VSP-MIKRON

40A/60V. Die Size-150mil.

Electrical Characteristics	Symbol	Unit	Spec. limit	Die Sort
Breakdown Voltage @ $I_R=10\text{mA}$	V_{BR}	V	60	65
Average Rectified Forward Current	$I_{F(AV)}$	A	40,0	-
DC Forward Voltage @ 25°C , $I_F=40,0\text{A}$ @ 25°C , $I_F=20,0\text{A}$	V_F	V	0,67 0,58	0,65 0,56
Maximum Reverse Current @ 25°C , $V_R=65\text{V}$ 25°C , $V_R=60\text{V}$ 125°C , $V_R=60\text{V}$	I_R	mA	- 0,50 350	0,60 0,45 300
Peak Forward Surge Current 8,3ms single half sine-wave superimposed on rated load (JEDEC METHOD)	I_{FSM}	A	400	-
Peak Repetitive Reverse Surge Current @ $2,0\mu\text{s}$, $f=1\text{kHz.}$, $T_J<150^\circ\text{C.}$	I_{RRM}	A	5,0	
Electrostatic Discharge Voltage. JEDEC Method. ESD HBM. Contact.	ESD	kV	± 8 (contact)	
Voltage Rate of Change	dV/dt	V/ μS	10.000	
Operating Junction Temperature	T_J	°C	150	



DIM	ITEM	μm
A_x A_y	Wafer Form Die Size	3810 3810
B_x B_y	Top Metal Size	3670 3670
D	Thickness	350max.
	Scribe line Width	80

Top metal: a) Al – for Wire Bonding;
b) Al-Ni-Ag – for Soldering.

Backside metal: Ti-Ni-Ag.